

NI 628x Specifications

Specifications listed below are typical at 25 °C unless otherwise noted.

Analog Input

Number of channels

NI 6280/NI 6281 8 differential or
16 single ended

NI 6284/NI 6289 16 differential or
32 single ended

ADC resolution 18 bits

DNL No missing codes
guaranteed

INL Refer to the *AI Absolute
Accuracy Tables*

Sampling rate

Maximum 625 kS/s single channel,
500 kS/s multi-channel

Minimum 0 S/s

Timing accuracy 50 ppm of sample rate

Timing resolution 50 ns

Input coupling DC

Input range ± 10 V, ± 5 V, ± 2 V, ± 1 V,
 ± 0.5 V, ± 0.2 V, ± 0.1 V

Maximum working voltage for analog inputs
(signal + common mode) ± 11 V of AI GND

CMRR (DC to 60 Hz) 110 dB

Input impedance

AI+ to AI GND >10 G Ω in parallel
with 100 pF

AI- to AI GND >10 G Ω in parallel
with 100 pF

Input bias current ± 100 pA

Crosstalk (at 100 kHz)

Adjacent channels -75 dB

Non-adjacent channels -95 dB

Small signal bandwidth (-3 dB) 750 kHz filter off,
40 kHz filter on

Input FIFO size 2,047 samples

Scan list memory 4,095 entries

Data transfers DMA (scatter-gather),
interrupts,
programmed I/O

Overvoltage protection

(AI $<0..31>$, AI SENSE, AI SENSE 2)

Device on ± 25 V for up to
eight AI pins

Device off ± 15 V for up to
eight AI pins

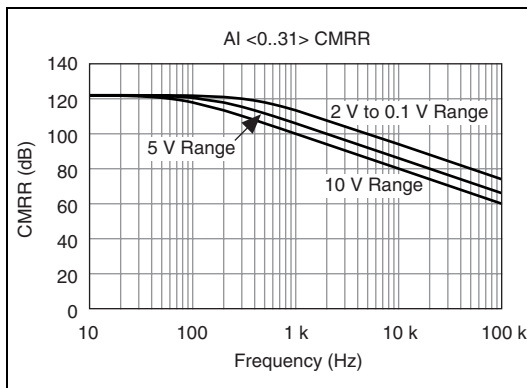
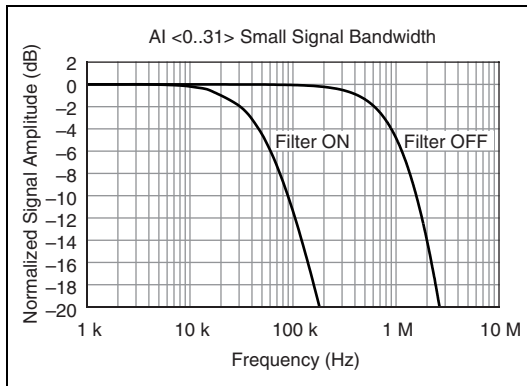
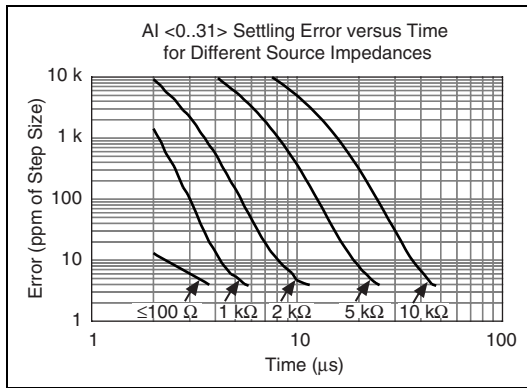
Input current during

overvoltage condition ± 20 mA max/AI pin

Settling Time for Multichannel Measurements

Range	Filter Off		Filter On
	± 15 ppm of Step (± 4 LSB for Full Scale Step)	± 4 ppm of Step (± 1 LSB for Full Scale Step)	± 4 ppm of Step (± 1 LSB for Full Scale Step)
± 10 V, ± 5 V	2 μ s	8 μ s	50 μ s
± 2 V, ± 1 V, ± 0.5 V	2.5 μ s	8 μ s	50 μ s
± 0.2 V, ± 0.1 V	3 μ s	8 μ s	50 μ s

Typical Performance Graphs



Analog Triggers

Number of triggers 1

Source

NI 6280/NI 6281 AI <0..15>, APFI 0
 NI 6284/NI 6289 AI <0..31>, APFI <0..1>

Functions Start Trigger,
 Reference Trigger,
 Pause Trigger,
 Sample Clock,
 Convert Clock,
 Sample Clock Timebase

Source level

(AI <0..31>) ±full scale
 (APFI <0..1>) ±10 V

Resolution 10 bits

Modes Level triggering,
 level triggering
 with hysteresis,
 window triggering

Bandwidth (–3 dB)

AI <0..31> 700 kHz filter off,
 40 kHz filter on
 APFI <0..1> 5 MHz

Accuracy ±1%

APFI <0..1> characteristics

Input impedance 10 kΩ

Coupling DC

Protection

Power on ±30 V

Power off ±15 V

Analog Output

Number of channels

NI 6280.....	0
NI 6281.....	2
NI 6284.....	0
NI 6289.....	4

DAC resolution..... 16 bits

DNL..... ±1 LSB

Monotonicity..... 16 bit guaranteed

Accuracy..... Refer to the [AO Absolute Accuracy Table](#)

Maximum update rate

1 channel.....	2.86 MS/s
2 channels.....	2.00 MS/s
3 channels.....	1.54 MS/s
4 channels.....	1.25 MS/s

Timing accuracy..... 50 ppm of sample rate

Timing resolution..... 50 ns

Output range..... offset ± reference, includes ±10 V, ±5 V, ±2 V, and ±1 V calibrated ranges

Offset..... 0 V, 5 V, APFI <0..1>, AO <0..3>¹

Reference..... 10 V, 5 V, 2 V, 1 V, APFI <0..1>, AO <0..3>¹

Maximum output level..... ±11 V

Output coupling..... DC

Output impedance..... 0.2 Ω

Output current drive..... ±5 mA

Overdrive protection..... ±25 V

Overdrive current..... 20 mA

Power-on state..... ±5 mV

Power-on glitch..... 2.3 V peak for 1.2 s

Output FIFO size..... 8,191 samples shared among channels used

Data transfers..... DMA (scatter-gather), interrupts, programmed I/O

AO waveform modes:

- Non-periodic waveform
- Periodic waveform regeneration mode from onboard FIFO
- Periodic waveform regeneration from host buffer including dynamic update

Settling time, full scale step

15 ppm (1 LSB)..... 3 μs

Slew rate..... 20 V/μs

Glitch energy at midscale transition, ±10 V range

Magnitude..... 15 mV

Duration..... 0.5 μs

External Reference

APFI <0..1> characteristics

Input impedance..... 10 kΩ

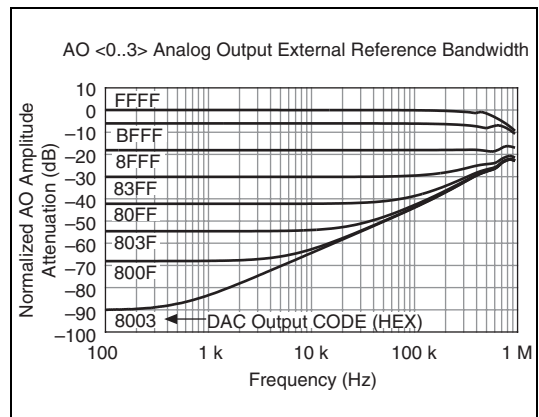
Coupling..... DC

Protection

Power on..... ±30 V

Power off..... ±15 V

Range..... ±11 V



Calibration (AI and AO)

Recommended warm-up time..... 15 minutes

Calibration interval..... 2 years

¹ An AO channel cannot be a reference or offset to itself.

AI Absolute Accuracy Table (Filter On)

Nominal Range		Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Reference Tempco	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	INL Error (ppm of Range)	Random Noise, σ (μ V rms)	Absolute Accuracy at Full Scale ¹ (μ V)	Sensitivity ² (μ V)
Positive Full Scale	Negative Full Scale									
10	-10	40	17	1	8	11	10	60	980	24
5	-5	45	17	1	8	11	10	30	510	12
2	-2	45	17	1	8	13	10	12	210	4.8
1	-1	55	17	1	15	15	10	7	120	2.8
0.5	-0.5	55	17	1	30	20	10	4	70	1.6
0.2	-0.2	75	17	1	45	35	10	3	39	1.2
0.1	-0.1	120	17	1	60	60	10	2	28	0.8

AbsoluteAccuracy = Reading · (GainError) + Range · (OffsetError) + NoiseUncertainty

GainError = ResidualGainError + GainTempco · (TempChangeFromLastInternalCal) + ReferenceTempco · (TempChangeFromLastExternalCal)

OffsetError = ResidualOffsetError + OffsetTempco · (TempChangeFromLastInternalCal) + INL_Error

NoiseUncertainty = $\frac{\text{RandomNoise} \cdot 3}{\sqrt{100}}$ For a coverage factor of 3 σ and averaging 100 points.

¹ Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

TempChangeFromLastExternalCal = 10 °C

TempChangeFromLastInternalCal = 1 °C

number_of_readings = 100

CoverageFactor = 3 σ

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

GainError = 40 ppm + 17 ppm · 1 + 1 ppm · 10

OffsetError = 8 ppm + 11 ppm · 1 + 10 ppm

NoiseUncertainty = $\frac{60 \mu\text{V} \cdot 3}{\sqrt{100}}$ NoiseUncertainty = 18 μ V

AbsoluteAccuracy = 10 V · (GainError) + 10 V · (OffsetError) + NoiseUncertainty Absolute Accuracy = 980 μ V

² Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

AI Absolute Accuracy Table (Filter Off)

Nominal Range		Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Reference Tempco	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	INLE Error (ppm of Range)	Random Noise, σ (μ Vrms)	Absolute Accuracy at Full Scale ¹ (μ V)	Sensitivity ² (μ V)
Positive Full Scale	Negative Full Scale									
10	-10	45	17	1	10	11	10	70	1050	28.0
5	-5	50	17	1	10	11	10	35	550	14.0
2	-2	50	17	1	10	13	10	15	230	6.0
1	-1	60	17	1	17	15	10	12	130	4.8
0.5	-0.5	60	17	1	32	20	10	10	80	4.0
0.2	-0.2	80	17	1	47	35	10	9	43	3.6
0.1	-0.1	120	17	1	62	60	10	9	31	3.6

AbsoluteAccuracy = Reading · (GainError) + Range · (OffsetError) + NoiseUncertainty

GainError = ResidualAIGainError + GainTempco · (TempChangeFromLastInternalCal) + ReferenceTempco · (TempChangeFromLastExternalCal)

OffsetError = ResidualAIOffsetError + OffsetTempco · (TempChangeFromLastInternalCal) + INL_Error

NoiseUncertainty = $\frac{\text{RandomNoise} \cdot 3}{\sqrt{100}}$ For a coverage factor of 3 σ and averaging 100 points.

¹ Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

TempChangeFromLastExternalCal = 10 °C

TempChangeFromLastInternalCal = 1 °C

number_of_readings = 100

CoverageFactor = 3 σ

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

GainError = 45 ppm + 17 ppm · 1 + 1 ppm · 10

GainError = 72 ppm

OffsetError = 10 ppm + 11 ppm · 1 + 10 ppm

OffsetError = 31 ppm

NoiseUncertainty = $\frac{70 \mu\text{V} \cdot 3}{\sqrt{100}}$ NoiseUncertainty = 21 μ V

AbsoluteAccuracy = 10 V · (GainError) + 10 V · (OffsetError) + NoiseUncertainty Absolute Accuracy = 1050 μ V

² Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

AO Absolute Accuracy Table

Nominal Range		Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Reference Tempco	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	INL Error (ppm of Range)	Absolute Accuracy at Full Scale ¹ (µV)
Positive Full Scale	Negative Full Scale							
10	-10	55	15	1	30	12	32	1540
5	-5	60	15	1	30	17	32	820
2	-2	65	25	1	40	30	32	404
1	-1	85	25	1	57	50	32	259

$AbsoluteAccuracy = OutputValue \cdot (GainError) + Range \cdot (OffsetError)$
 $GainError = ResidualGainError + GainTempco \cdot (TempChangeFromLastInternalCal) + ReferenceTempco \cdot (TempChangeFromLastExternalCal)$
 $OffsetError = ResidualOffsetError + AOffsetTempco \cdot (TempChangeFromLastInternalCal) + INL_Error$

¹ Absolute Accuracy at full scale numbers is valid immediately following internal calibration and assume the device is operating within 10 °C of the last external calibration.

Digital I/O/PFI

Static Characteristics

Number of channels	
NI 6280/NI 6281	24 total 8 (P0.<0..7>) 16 (PFI <0..7>/P1, PFI <8..15>/P2)
NI 6284/NI 6289	48 total 32 (P0.<0..31>) 16 (PFI <0..7>/P1, PFI <8..15>/P2)
I/O type	5 V TTL/CMOS compatible
Ground reference	D GND
Direction control	Each terminal individually programmable as input or output
Pull-down resistor	50 k Ω to 75 k Ω
Input voltage protection ¹	± 20 V on up to 2 pins

Waveform Characteristics (Port 0 Only)

Terminals used	
NI 6280/NI 6281	Port 0 (P0.<0..7>)
NI 6284/NI 6289	Port 0 (P0.<0..31>)
Port/sample size	
NI 6280/NI 6281	Up to 8 bits
NI 6284/NI 6289	Up to 32 bits
Waveform generation (DO) FIFO	2,047 samples
Waveform acquisition (DI) FIFO	2,047 samples
DO or DI Sample Clock frequency	0 to 10 MHz
DO or DI Sample Clock source ²	Any PFI, RTSI, AI Sample or Convert Clock, AO Sample Clock, Ctr <i>n</i> Internal Output, and many other signals

PFI/Port 1/Port 2 Functionality

Functionality	Static digital input, static digital output, timing input, timing output
Timing output sources	Many AI, AO, counter, DI, DO timing signals
Debounce filter settings	125 ns, 6.425 μ s, 2.54 ms, disable; high and low transitions; selectable per input

Recommended Operation Conditions

Level	Min	Max
Input high voltage (V_{IH})	2.2 V	5.25 V
Input low voltage (V_{IL})	0 V	0.8 V
Output high current (I_{OH})		
P0.<0..31>	—	-24 mA
PFI <0..15>/P1/P2	—	-16 mA
Output low current (I_{OL})		
P0.<0..31>	—	24 mA
PFI <0..15>/P1/P2	—	16 mA

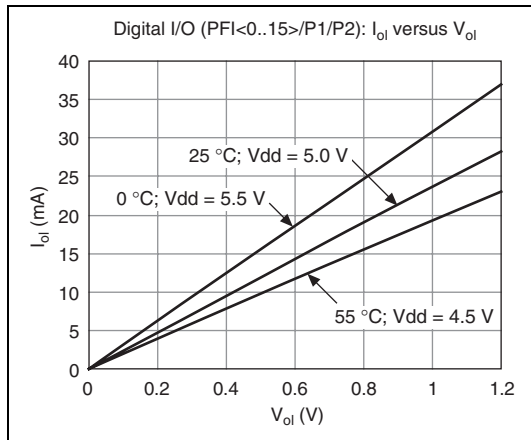
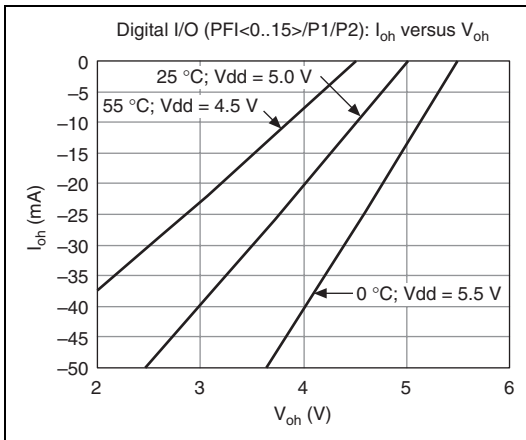
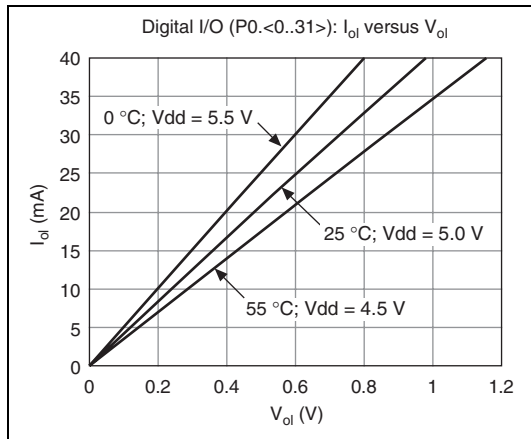
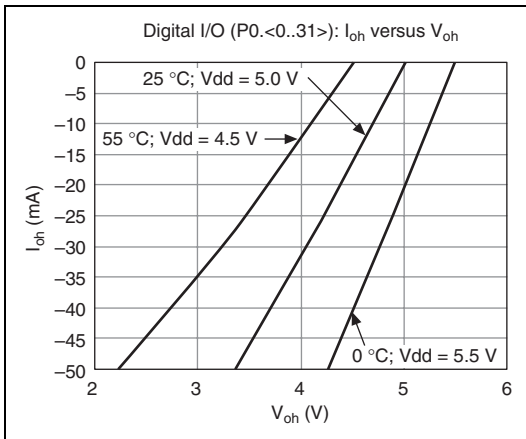
Electrical Characteristics

Level	Min	Max
Positive-going threshold (V_{T+})	—	2.2 V
Negative-going threshold (V_{T-})	0.8 V	—
Delta VT hysteresis ($V_{T+} - V_{T-}$)	0.2 V	—
I_{IL} input low current ($V_{in} = 0$ V)	—	-10 μ A
I_{IH} input high current ($V_{in} = 5$ V)	—	250 μ A

¹ Stresses beyond those listed under *Input voltage protection* may cause permanent damage to the device.

² The digital subsystem does not have its own dedicated internal timing engine. Therefore, a sample clock must be provided from another subsystem on the device or an external source.

Digital I/O Characteristics



General-Purpose Counter/Timers

Number of counter/timers	2
Resolution	32 bits
Counter measurements	Edge counting, pulse, semi-period, period, two-edge separation
Position measurements	X1, X2, X4 quadrature encoding with Channel Z reloading; two-pulse encoding
Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling
Internal base clocks	80 MHz, 20 MHz, 100 kHz
External base clock frequency	0 to 20 MHz
Base clock accuracy	50 ppm
Inputs	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Routing options for inputs	Any PFI, RTSI, PXI_TRIG, PXI_STAR, analog trigger, many internal signals
FIFO	2 samples
Data transfers	Dedicated scatter-gather DMA controller for each counter/timer; interrupts; programmed I/O

Frequency Generator

Number of channels	1
Base clocks	10 MHz, 100 kHz
Divisors	1 to 16
Base clock accuracy	50 ppm
Output can be available on any PFI or RTSI terminal.	

Phase-Locked Loop (PLL)

Number of PLLs	1
Reference signal	PXI_STAR, PXI_CLK10, RTSI <0..7>
Output of PLL	80 MHz Timebase; other signals derived from 80 MHz Timebase including 20 MHz and 100 kHz Timebases

External Digital Triggers

Source	Any PFI, RTSI, PXI_TRIG, PXI_STAR
Polarity	Software-selectable for most signals
Analog input function	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase
Analog output function	Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Counter/timer function	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Digital waveform generation (DO) function	Sample Clock
Digital waveform acquisition (DI) function	Sample Clock

Device-To-Device Trigger Bus

PCI devices	RTSI <0..7> ¹
PXI devices	PXI_TRIG <0..7>, PXI_STAR
Output selections	10 MHz Clock; frequency generator output; many internal signals
Debounce filter settings	125 ns, 6.425 μ s, 2.54 ms, disable; high and low transitions; selectable per input

¹ In other sections of this document, *RTSI* refers to RTSI <0..7> for PCI devices or PXI_TRIG <0..7> for PXI devices.

Bus Interface

PCI or PXI	3.3 V or 5 V signal environment
DMA channels.....	6, analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1

Power Requirements

Current draw from bus during no-load condition	
+5 V	0.03 A
+3.3 V	0.78 A
+12 V	0.40 A
-12 V.....	0.06 A
Current draw from bus during AI and AO overvoltage condition	
+5 V	0.03 A
+3.3 V	1.26 A
+12 V	0.43 A
-12 V.....	0.06 A

Power available from +5 V terminal.....	1 A max, each connector, with self-resetting fuse
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Other power limit for PXI devices.....	Current drawn from +5 V terminals and all P0/PFI/P1/P2 terminals should not exceed 2 A
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Physical Requirements

Printed circuit board dimensions	
NI PCI-6280/6281/6284/6289	10.6 cm × 15.5 cm (4.2 in. × 6.1 in.)
NI PXI-6280/6281/6284/6289	Standard 3U PXI
I/O connector	
NI 6280/NI 6281	1 68-pin VHDCI
NI 6284/NI 6289	2 68-pin VHDCI

Maximum Working Voltage¹

NI 6280/NI 6281/NI 6284/NI 6289	
Channel to earth	11 V, Measurement Category I



Caution Do *not* use for measurements within Categories II, III, or IV.

Environmental

Operating temperature	0 to 55 °C
Storage temperature	-20 to 70 °C
Humidity	10 to 90% RH, noncondensing
Maximum altitude.....	2,000 m
Pollution Degree (indoor use only).....	2

Safety

This product is designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1
- CAN/CSA-C22.2 No. 61010-1



Note For UL and other safety certifications, refer to the product label, or visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Electromagnetic Compatibility

Emissions	EN 55011 Class A at 10 m FCC Part 15A above 1 GHz
Immunity.....	EN 61326:1997 + A2:2001, Table 1
CE, C-Tick, and FCC Part 15 (Class A) Compliant	



Note For EMC compliance, operate this device with shielded cabling.

¹ *Maximum working voltage* refers to the signal voltage plus the common-mode voltage.

CE Compliance

This product meets the essential requirements of applicable European Directives, as amended for CE Marking, as follows:

Low-Voltage Directive (safety) 73/23/EEC

Electromagnetic Compatibility

Directive (EMC) 89/336/EEC



Note Refer to the Declaration of Conformity (DoC) for this product for any additional regulatory compliance information. To obtain the DoC for this product, visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

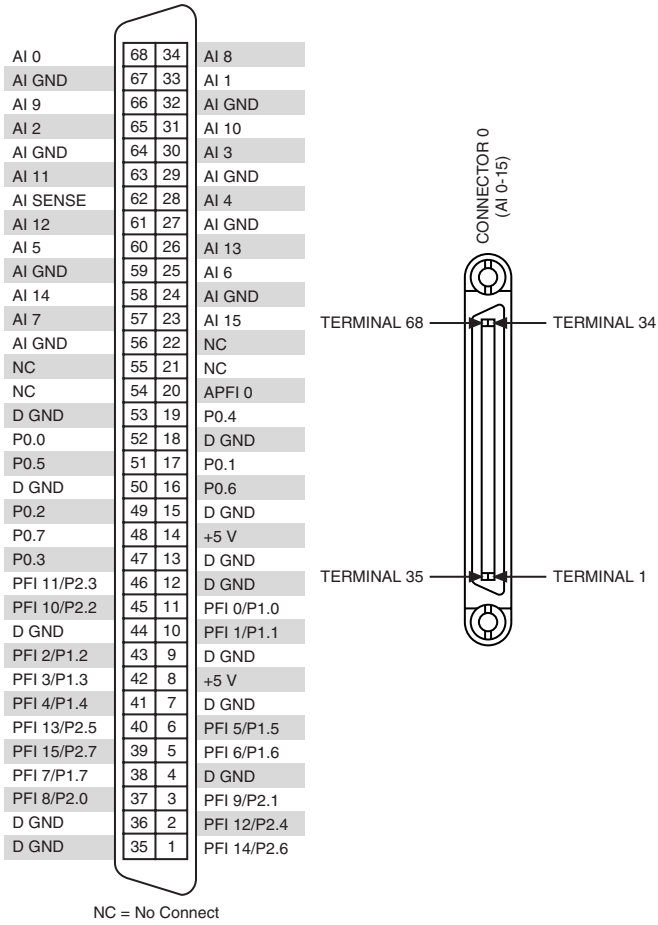


Figure 1. NI 6280 Pinout

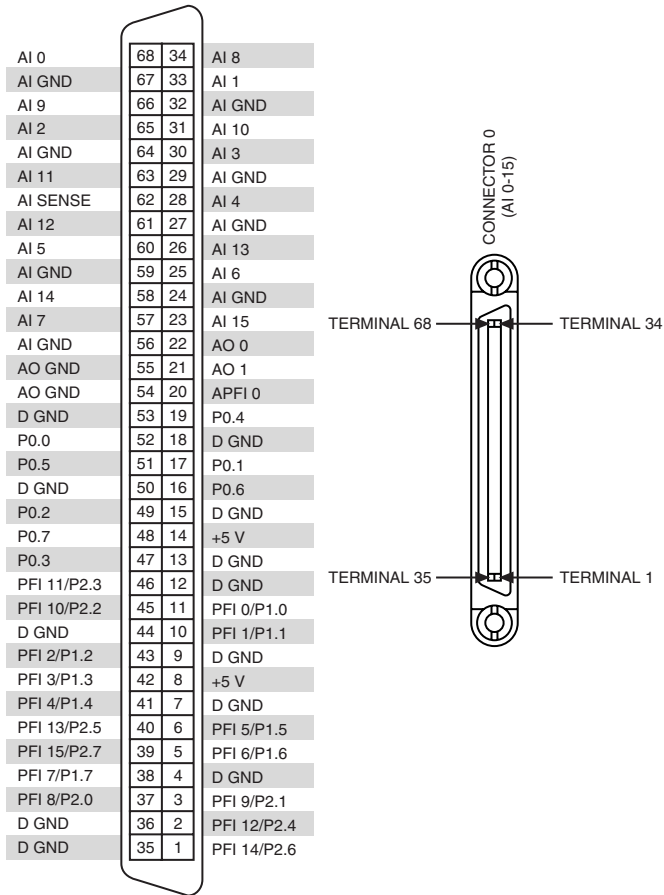


Figure 2. NI 6281 Pinout

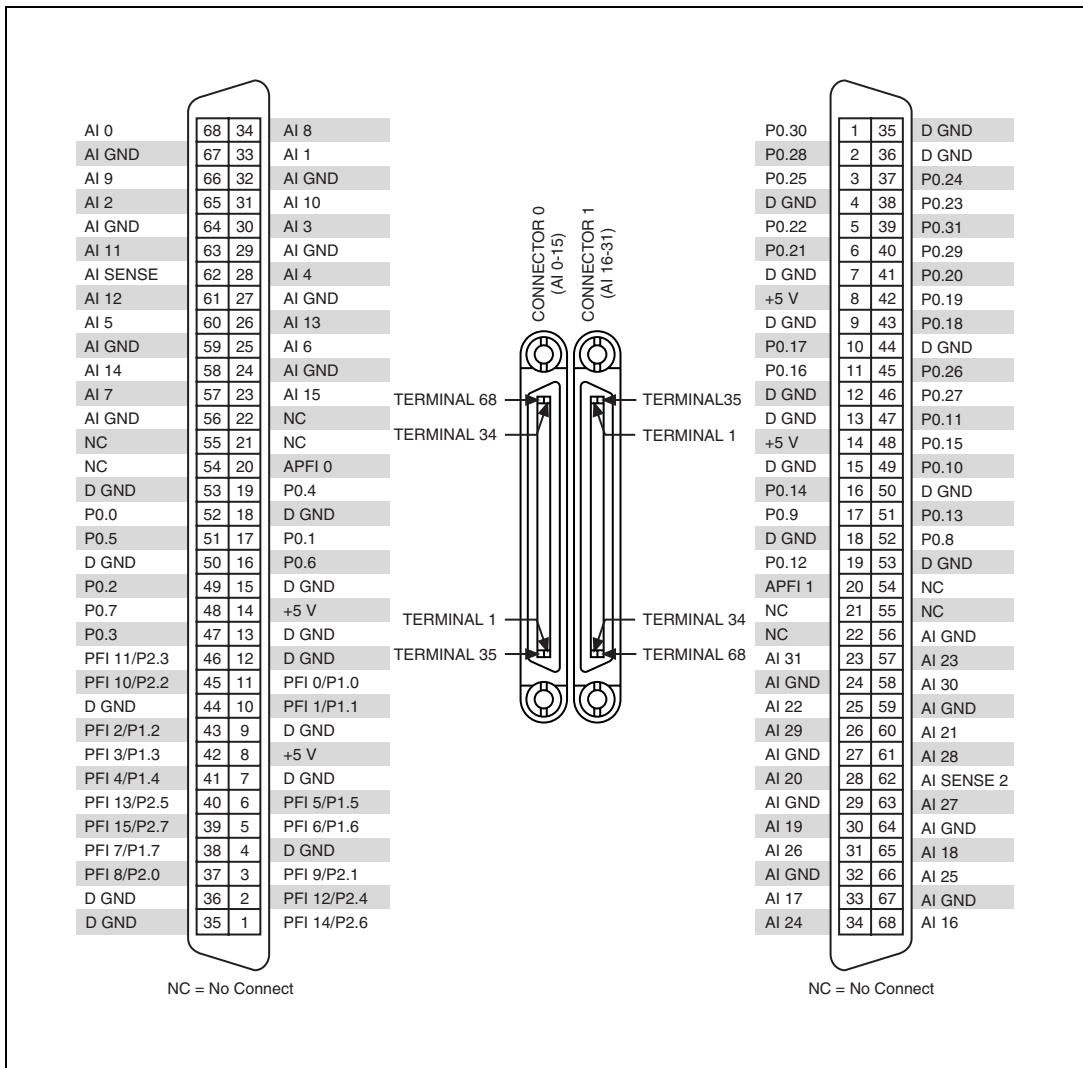


Figure 3. NI 6284 Pinout

